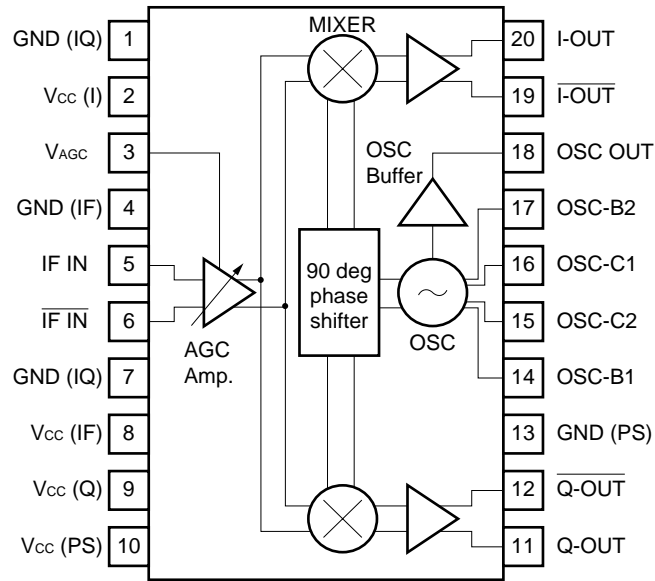
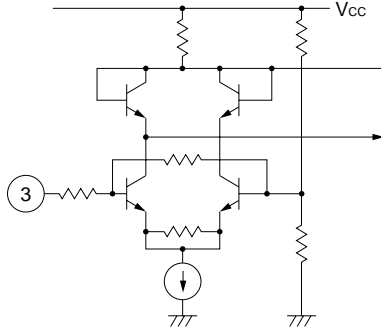
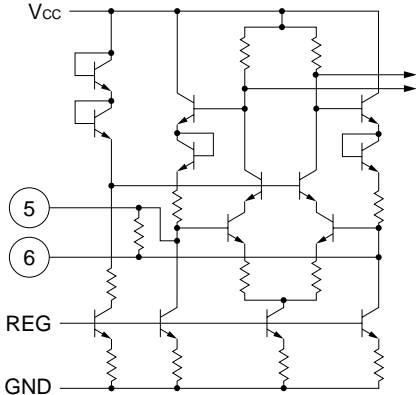
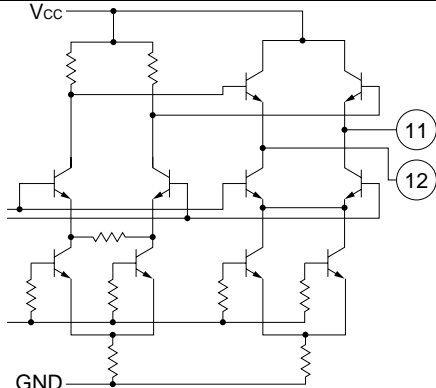


INTERNAL BLOCK DIAGRAM AND PIN CONFIGURATION (Top View)



PIN FUNCTIONS

PIN No.	PIN NAME	PIN VOLTAGE TYP. (V)	FUNCTION AND EXPLANATION	EQUIVALENT CIRCUIT
1	GND (IQ)	0.0	Ground pin of IQ outputs block.	
2	V _{CC} (I)	5.0	Power supply pin of I-output.	
3	V _{AGC}	0 to 4	Gain control pin. <ul style="list-style-type: none"> @ measurement circuit 1 V_{AGC} = 0 V: Full gain V_{AGC} = 4 V: Full reduction @ measurement circuit 2 V_{AGC} = 0 V: Full gain V_{AGC} = 5 V: Full reduction 	
4	GND (IF)	0.0	Ground pin of IF, MIX, REG block.	
5	IFin	2.2	IF input pins. In case of single input, 5 pin or 6 pin should be grounded through capacitor.	
6	IFin	2.2		
7	GND (IQ)	0.0	Ground pin of IQ outputs block.	
8	V _{CC} (IF)	5.0	Power supply pin of IF, MIX, REG block.	
9	V _{CC} (Q)	5.0	Power supply pin of Q-output.	
10	V _{CC} (PS)	5.0	Power supply pin of Phase Shifter block.	
11	Qout	2.7	Q-signal output pin. 11 pin and 12 pin are balance outputs.	
12	Qout	2.7		

PIN No.	PIN NAME	PIN VOLTAGE TYP. (V)	FUNCTION AND EXPLANATION	EQUIVALENT CIRCUIT	
13	GND (PS)	0.0	Ground pin of Phase Shifter block.		
			External local	SAW (single) SAW (balance)	
14	OSC-B1	3.1	Oscillator signal input pin. In case of single input, 14 pin or 17 pin should be grounded through capacitor.	Grounded through 1000 pF capacitor. Connected to SAW resonator through capacitor.	
15	OSC-C2	3.7	OPEN	Connected to SAW resonator through capacitor. Connected capacitor between 14 pin and 15 pin to oscillate with active feedback loop.	
16	OSC-C1	3.7	OPEN	OPEN	Connected capacitor between 16 pin and 17 pin to oscillate with active feedback loop.
17	OSC-B2	3.1	Oscillator signal input pin. In case of single input, 14 pin or 17 pin should be grounded through capacitor.	Connected to SAW resonator through capacitor. Connected to SAW resonator through capacitor.	
<div style="display: flex; justify-content: space-around;"> <div style="text-align: center;"> <p><External Local></p> </div> <div style="text-align: center;"> <p><SAW resonator (single)></p> </div> </div> <div style="text-align: center; margin-top: 10px;"> <p><SAW resonator (balance)></p> </div> <p style="text-align: center;">R: Resistor to adjust oscillator power.</p>					
18	OSC OUT	3.7	Oscillator signal output pin.		
19	\overline{lout}	2.7	I-signal output pin. 19 pin and 20 pin are balance outputs.		
20	lout	2.7			

ABSOLUTE MAXIMUM RATINGS (TA = 25°C unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITION	RATING	UNIT
Supply Voltage	V _{CC}		6.0	V
Power Dissipation 1	P _{D1}	T _A = 75 °C, V _{CC} = 5.25 V ^{*1}	500	mW
Operating Ambient Temperature 1	T _{A1}		-40 to +75	°C
Storage Temperature Range	T _{stg}		-55 to +150	°C

PARAMETER	SYMBOL	TEST CONDITION	RATING	UNIT
Supply Voltage	V _{CC}		6.0	V
Power Dissipation 2	P _{D2}	T _A = 80 °C, V _{CC} = 5.15 V ^{*1}	467	mW
Operating Ambient Temperature 2	T _{A2}		-40 to +80	°C
Storage Temperature Range	T _{stg}		-55 to +150	°C

*1 Mounted on 50 × 50 × 1.6 mm double epoxy glass board.

RECOMMENDED OPERATING RANGE

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Supply Voltage 1	V _{CC1}		4.75	5.0	5.25	V
Operating Ambient Temperature 1	T _{A1}		-40	+25	+75	°C
IF Input Level Range	P _{IF}	V _{out} = 1 V _{P-P}	-45	-	-25	dBm
Gain Control Voltage Range 1	V _{AGC1}	*1	0.0	-	4.0	V
Gain Control Voltage Range 2	V _{AGC2}	*2	0.0	-	5.0	V

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Supply Voltage 2	V _{CC2}		4.75	5.0	5.15	V
Operating Ambient Temperature 2	T _{A2}		-40	+25	+80	°C
IF Input Level Range	P _{IF}	V _{out} = 1 V _{P-P}	-45	-	-25	dBm
Gain Control Voltage Range 1	V _{AGC1}	*1	0.0	-	4.0	V
Gain Control Voltage Range 2	V _{AGC2}	*2	0.0	-	5.0	V

*1 By measurement circuit 1 External Resistance: 100 Ω

*2 By measurement circuit 2 External Resistance: 4.7 kΩ + 22 kΩ

ELECTRICAL CHARACTERISTICS (T_A = 25°C, V_{CC} = 5 V, Z_{in} = 50 Ω, Z_{out} = 1 kΩ)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Circuit Current	I _{CC}	No input signal	52.0	70.0	88.0	mA
IF Input Frequency	f _{IF}	f _{IQ} = 10 MHz, f _{IF} > f _{OSC} *1, 2	440	480	520	MHz
IQ Output Frequency	f _{IQ}	f _{IF} > f _{OSC} , V _{out} = 1 V _{P-P} , P _{OSC} = -8 dBm, CG (@f _{IQ} = 10 MHz) ±1 dB *1, 2	0.3	-	20	MHz
AGC Gain Control Range 1	GCR1	f _{IF} = 480 MHz, P _{IF} = -40 dBm, f _{OSC} = 470 MHz, P _{OSC} = -8 dBm, f _{IQ} = 10 MHz, V _{AGC} = 0 to 4 V *1	15	20	-	dB
AGC Gain Control Range 2	GCR2	f _{IF} = 480 MHz, P _{IF} = -40 dBm, f _{OSC} = 470 MHz, P _{OSC} = -8 dBm, f _{IQ} = 10 MHz, V _{AGC} = 0 to 5 V *2	15	20	-	dB
IQ Phase Balance	ΔΦ	f _{IF} = 480 MHz, f _{OSC} = 470 MHz, P _{OSC} = -8 dBm, f _{IQ} = 10 MHz, V _{out} = 1 V _{P-P} *1, 2	-2	0	+2	deg
IQ Amplitude Balance	ΔG	f _{IF} = 480 MHz, f _{OSC} = 470 MHz, P _{OSC} = -8 dBm, f _{IQ} = 10 MHz, V _{out} = 1 V _{P-P} *1, 2	-0.5	0	+0.5	dB
Output Voltage	V _{out}	f _{IQ} = 10 MHz *1, 2	-	1.0	-	V _{P-P}

*1 By measurement circuit 1 External Resistance: 100 Ω

*2 By measurement circuit 2 External Resistance: 4.7 kΩ + 22 kΩ

STANDARD CHARACTERISTICS (T_A = 25°C, V_{CC} = 5 V, Z_{in} = 50 Ω, Z_{out} = 1 kΩ)

PARAMETER	SYMBOL	TEST CONDITIONS	REFERENCE VALUE	UNIT
Conversion Gain	G _{CV}	f _{IF} = 480 MHz, f _{OSC} = 470 MHz, P _{OSC} = -8 dBm, f _{IQ} = 10 MHz, V _{AGC} = 0 V *1, 2	50	dB
Noise Figure (DSB)	NF	f _{IF} = 480 MHz, f _{OSC} = 470 MHz, P _{OSC} = -8 dBm, f _{IQ} = 10 MHz, V _{AGC} = 0 V *3	13	dB
Third Intermodulation Distortion	IM ₃	f _{IF1} = 480 MHz, f _{IF2} = 481 MHz, f _{OSC} = 470 MHz, P _{OSC} = -8 dBm, 0.708 V _{P-P} /tone *1, 2	40	dBc
LO to IF Isolation	I _{SO} (LO-IF)	f _{OSC} = 440 to 520 MHz, P _{OSC} = -8 dBm *1, 2	50	dB
LO to IQ Isolation	I _{SO} (LO-IQ)	f _{OSC} = 440 to 520 MHz, P _{OSC} = -8 dBm *1, 2	20	dB
Maximum Output Power	P _O (sat)	P _{OSC} = -8 dBm, f _{IQ} = 10 MHz *1, 2	0	dBm
IQ Output Impedance	Z _O (IQ)	f _{IQ} = 300 kHz to 20 MHz	30	Ω
IF Input Impedance	Z _{IN} (IF)	f _{IF} = 480 MHz, no tuning	160 - j30	Ω
IF Input Return Loss	RL (IF)	f _{IF} = 480 MHz, no tuning	5	dB

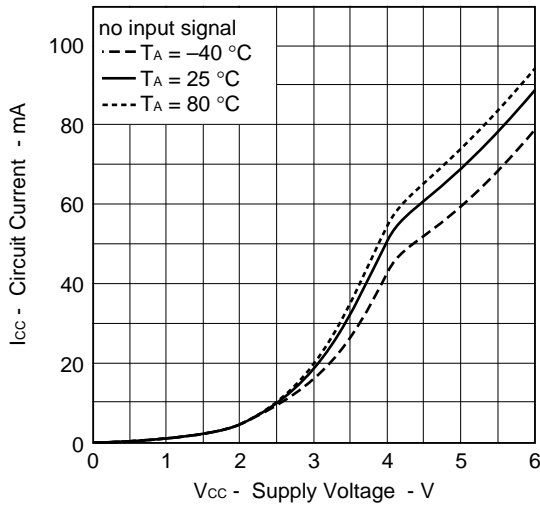
*1 By measurement circuit 1 External Resistance: 100 Ω

*2 By measurement circuit 2 External Resistance: 4.7 kΩ + 22 kΩ

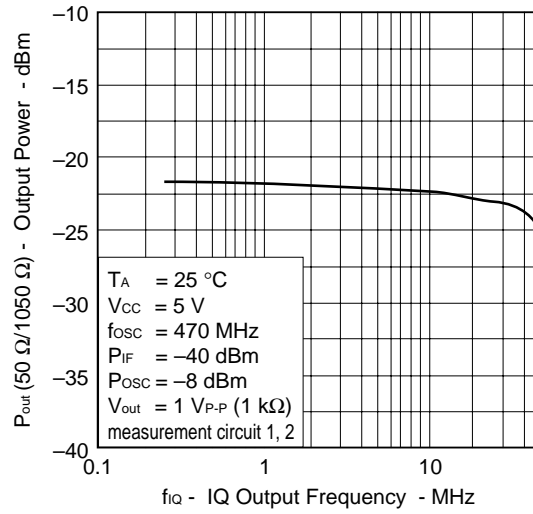
*3 By measurement circuit 3

TYPICAL CHARACTERISTICS

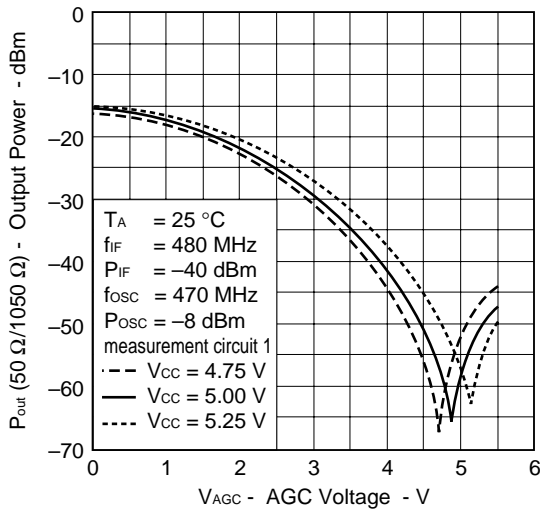
I_{cc} vs. V_{cc}



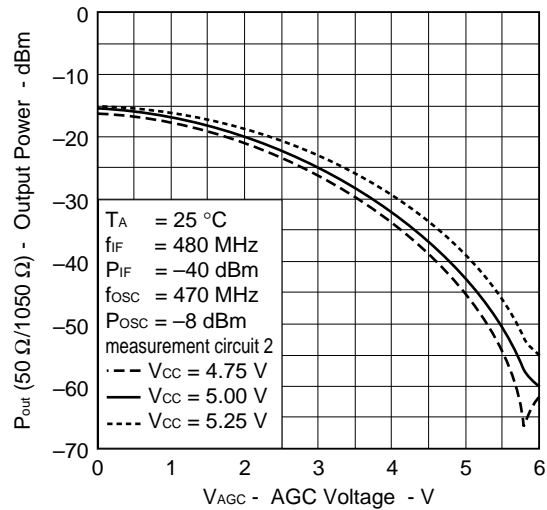
P_{out} vs. f_{iq}



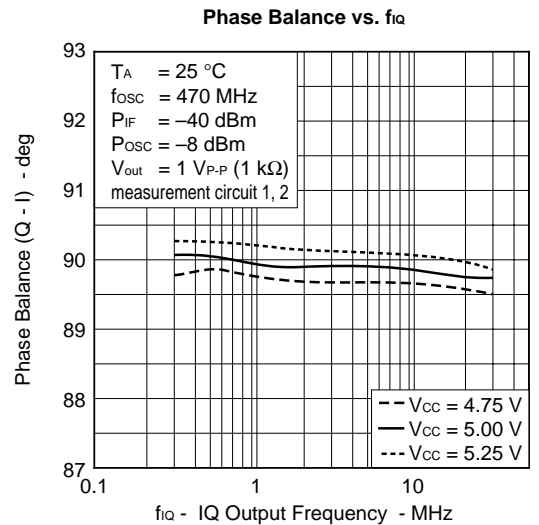
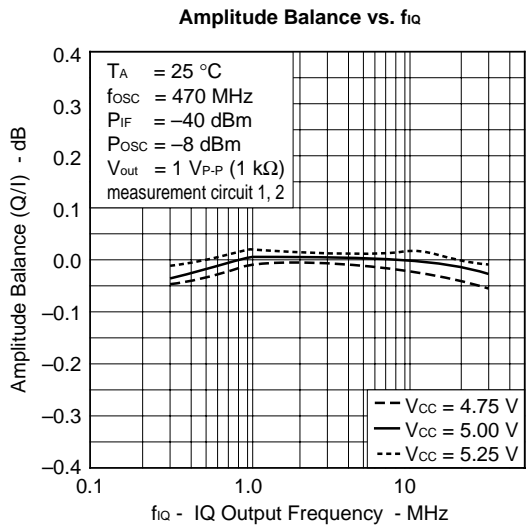
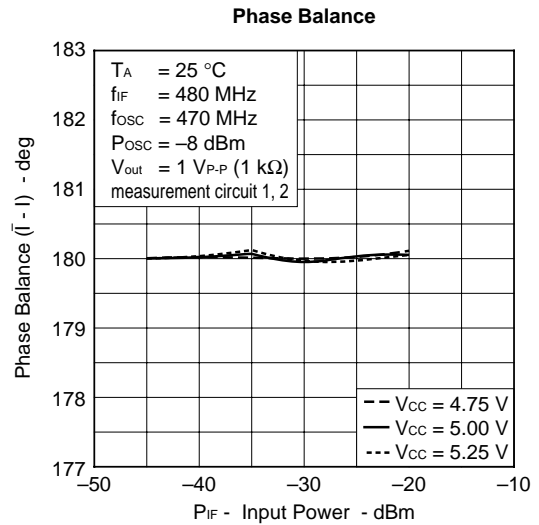
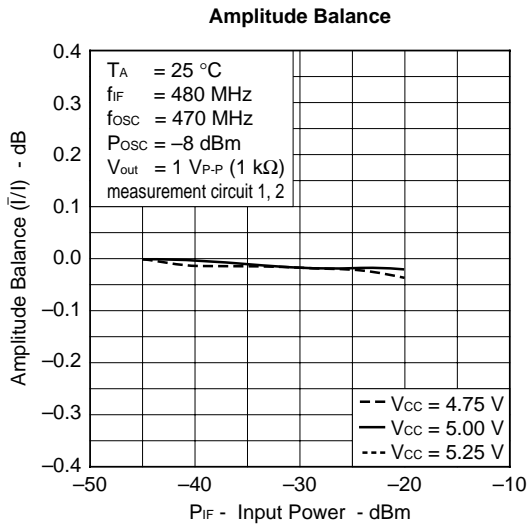
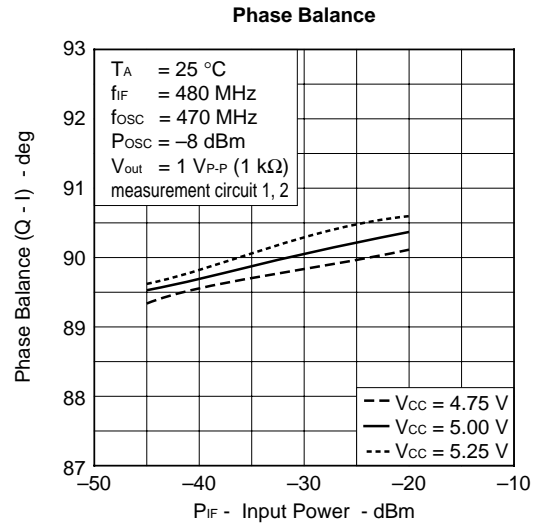
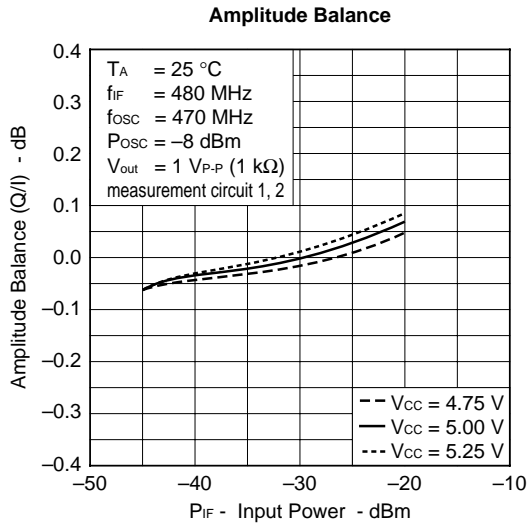
AGC Curve



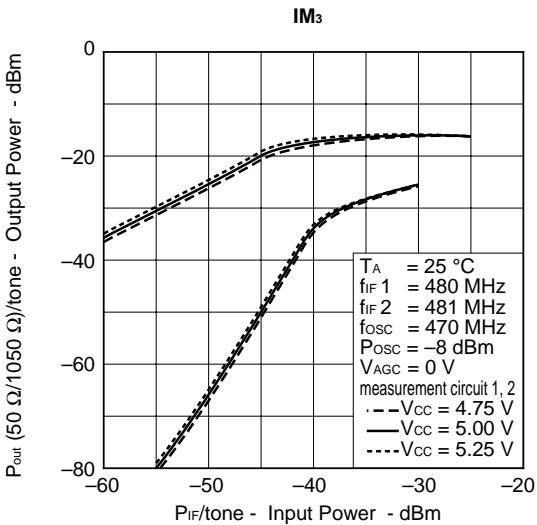
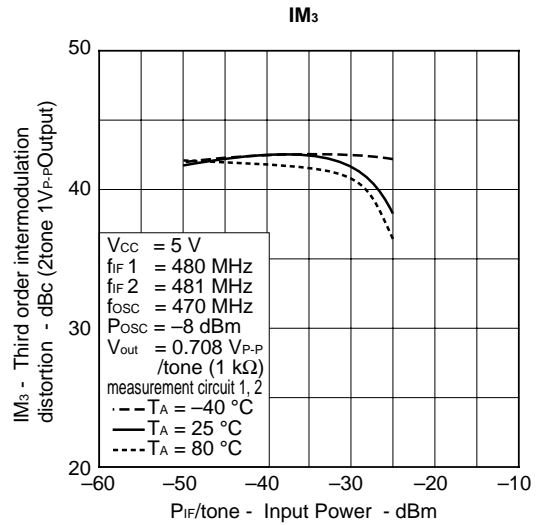
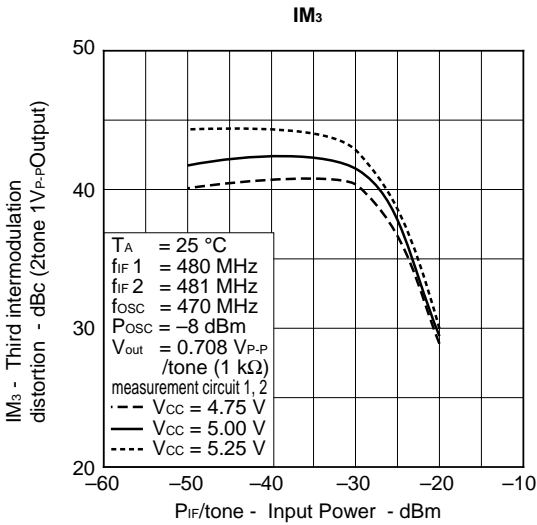
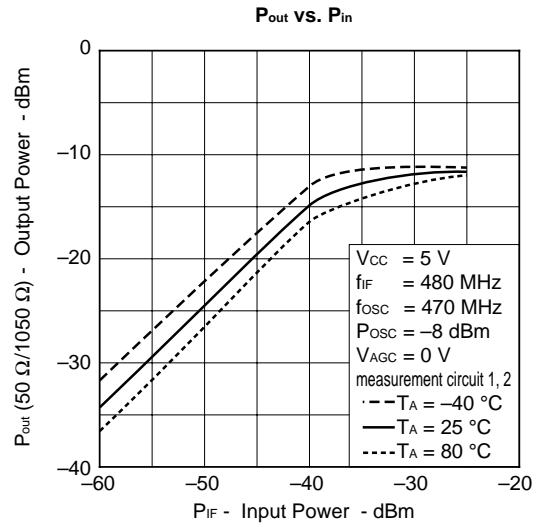
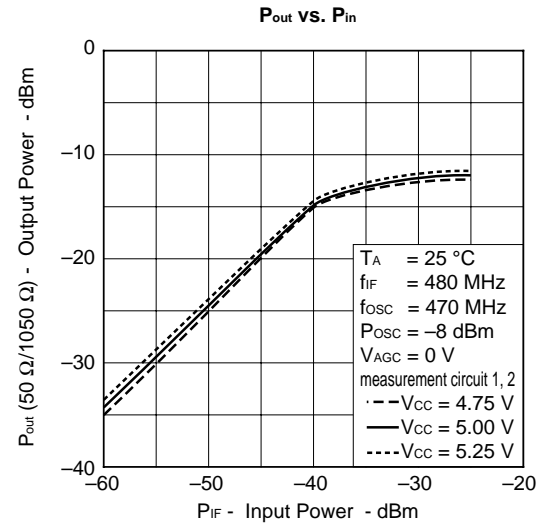
AGC Curve



TYPICAL CHARACTERISTICS



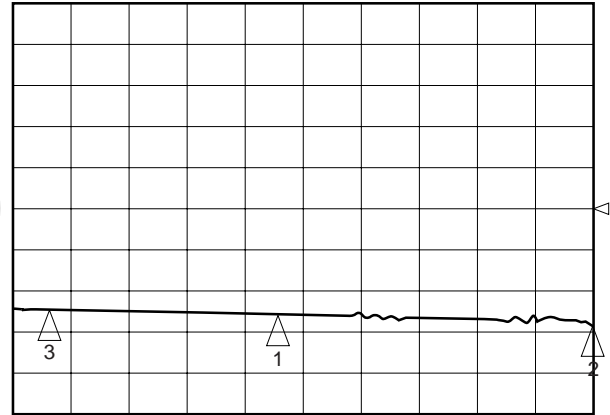
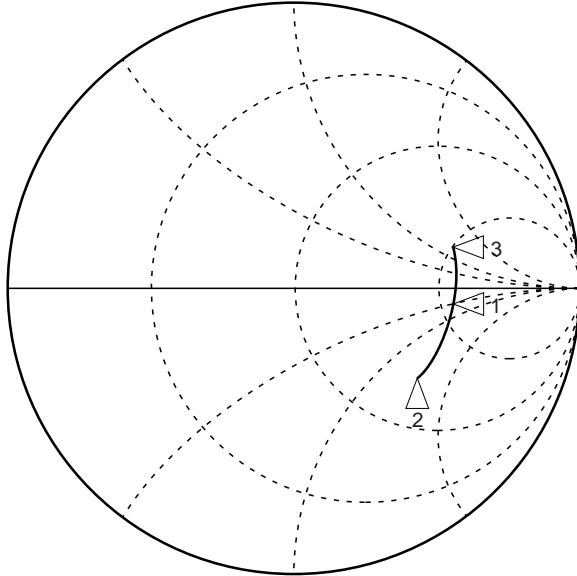
STANDARD CHARACTERISTICS



IF INPUT IMPEDANCE

S₂₂ Z
 REF 1.0 Units
 200.0 mUnits/
 hp

S₂₂ log MAG
 REF 0.0 dB
 Δ 2.0 dB/
 1 -5.1648 dB

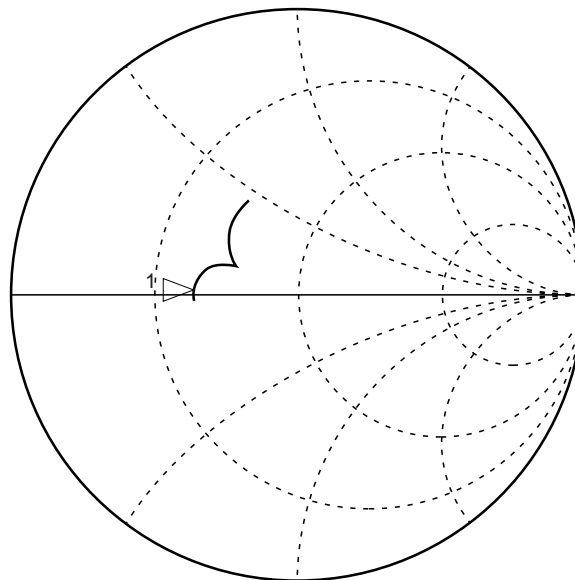


START 0.045000000 GHz
 STOP 1.000000000 GHz

MARKER 1	MARKER 2	MARKER 1
479.52 MHz	1.0 GHz	102.3 MHz
166.72 Ω	86.18 Ω	157.49 Ω
-31.203 Ω	-70.629 Ω	58.977 Ω

IQ OUTPUT IMPEDANCE (V_{CC} = 5 V)

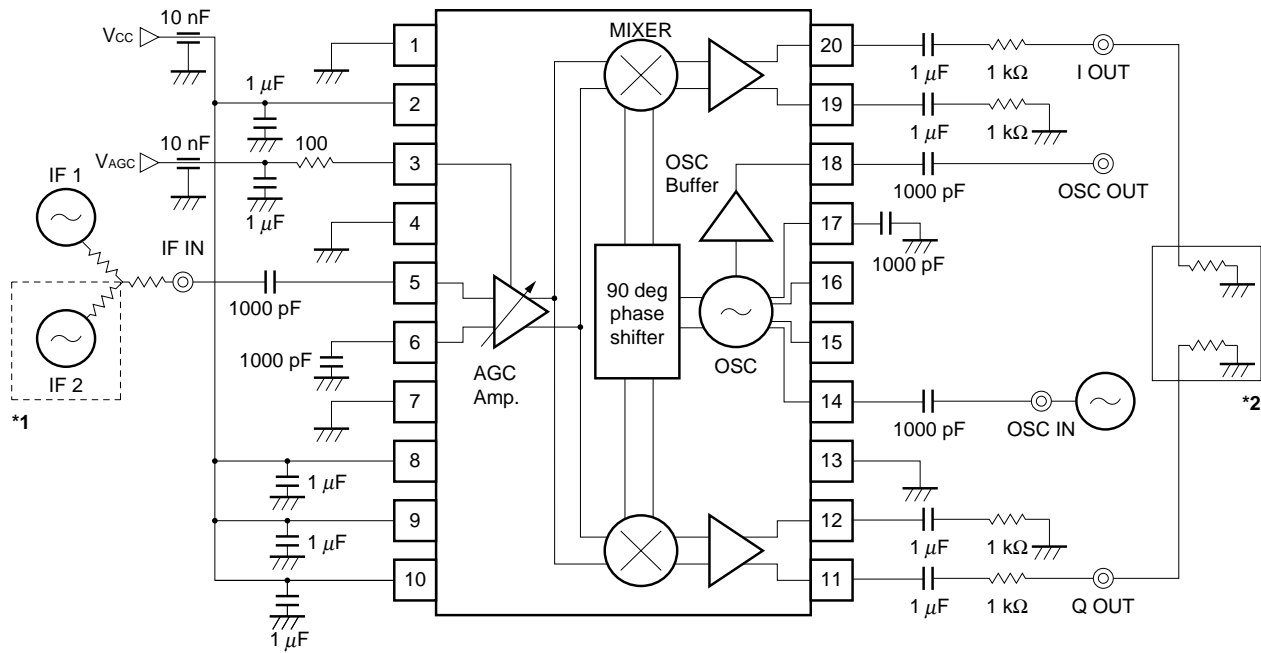
Δ: 24.541 Ω 1.1425 Ω 18.185 nH
 1 10.000 000 MHz



START 0.500 000 MHz

STOP 1 000.000 000 MHz

MEASUREMENT CIRCUIT 1

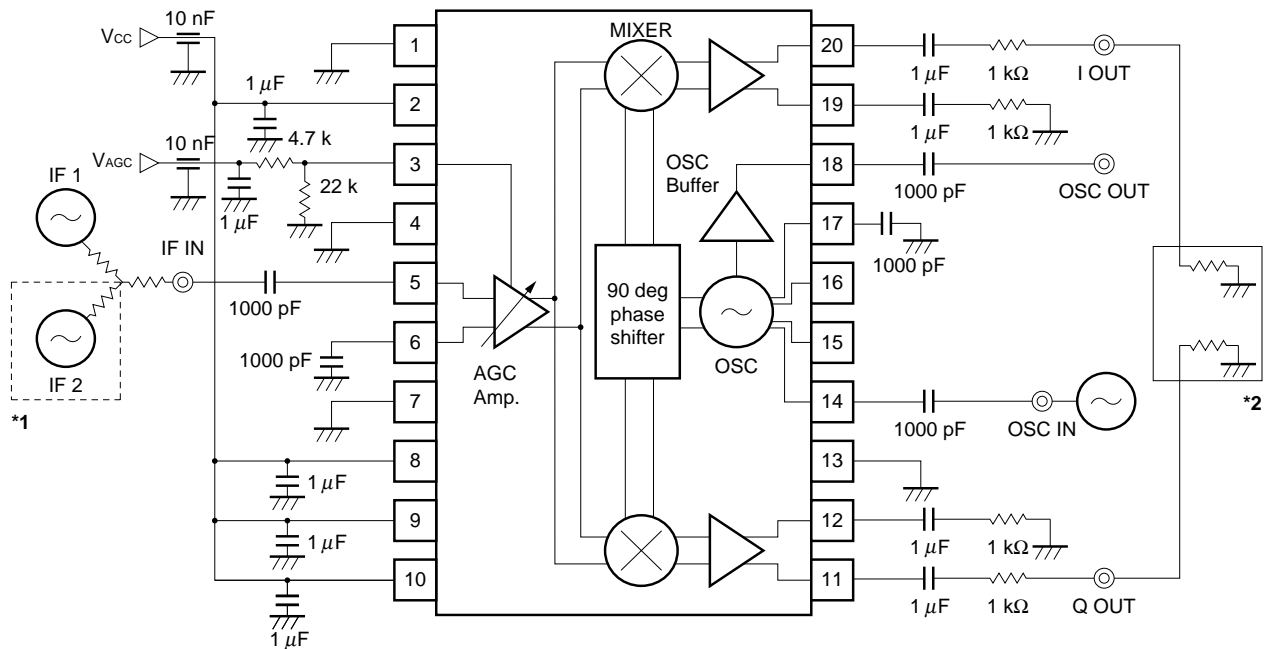


*1 In the case of measurement of IM3.

*2 • Vector Signal Analyzer or Vector Voltage Meter @ measurement of IQ phase balance and IQ amplitude balance.

• Spectrum Analyzer @ measurement of bandwidth and IM3.

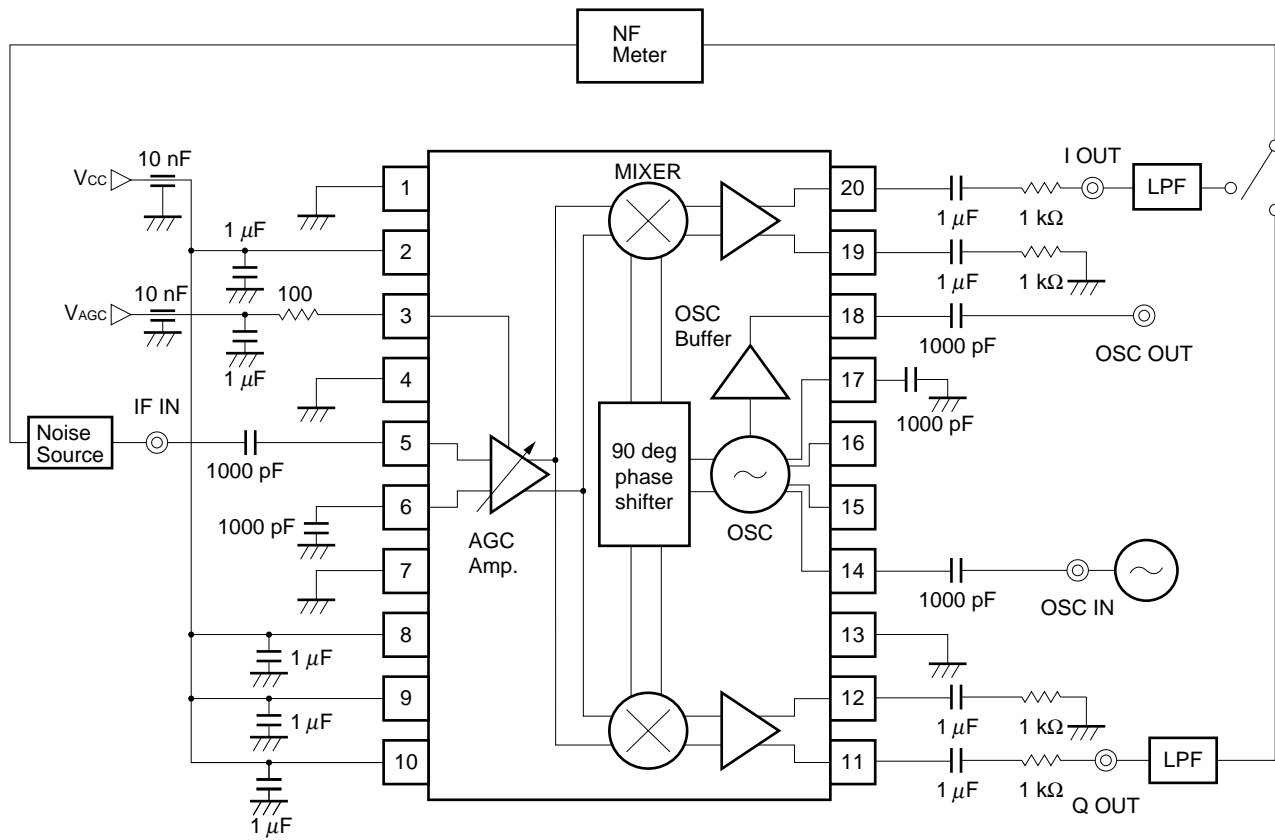
MEASUREMENT CIRCUIT 2



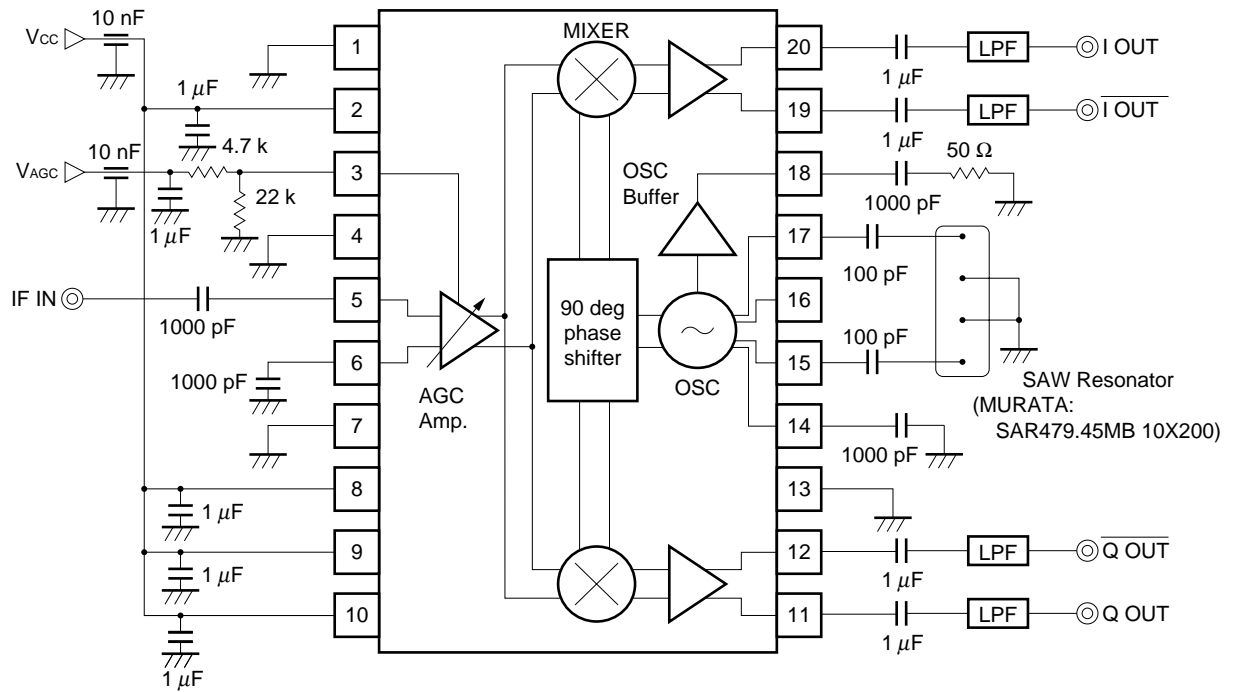
*1 In the case of measurement of IM3.

- *2 • Vector Signal Analyzer or Vector Voltage Meter @ measurement of IQ phase balance and IQ amplitude balance.
- Spectrum Analyzer @ measurement of bandwidth and IM3.

MEASUREMENT CIRCUIT 3

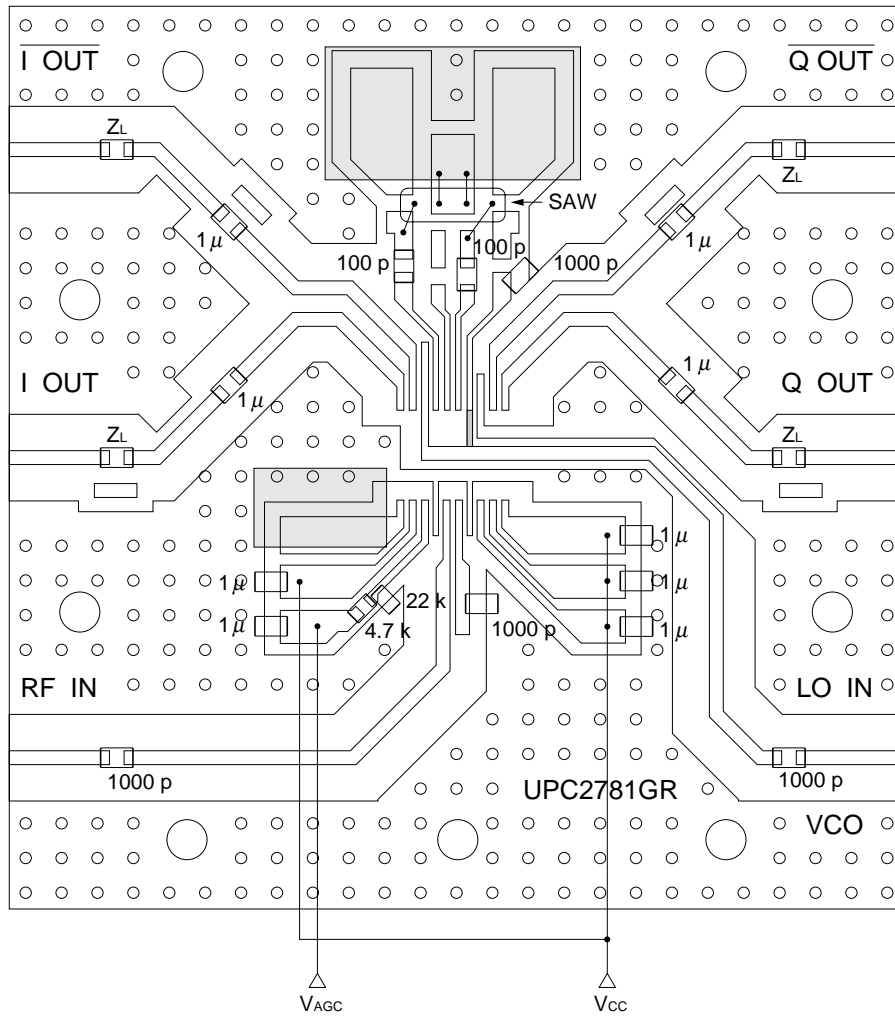





APPLICATION CIRCUIT EXAMPLE



The application circuits and their parameters are for reference only and are not intended for use in actual design-ins.

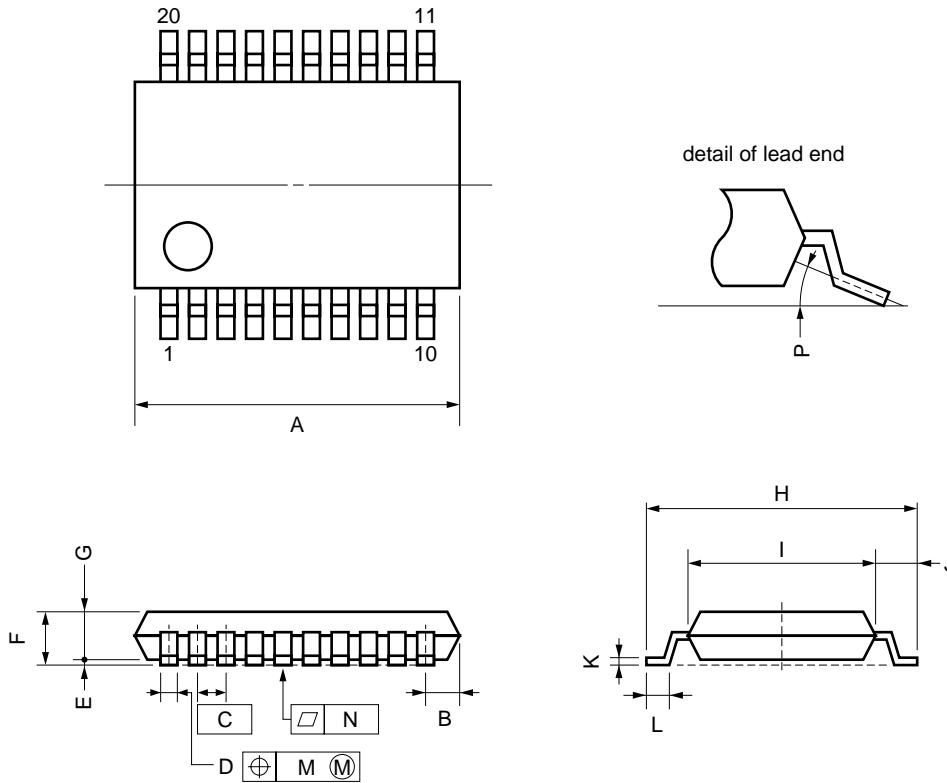
ILLUSTRATION OF THE APPLICATION CIRCUIT ASSEMBLED ON EVALUATION BOARD



- NOTES**
-  shows short circuited strip for ground
 -  Pattern should be removed on this application
 -  shows through holes

PACKAGE DIMENSIONS

20 PIN PLASTIC SSOP (225 mil)
(UNIT: mm)



NOTE

Each lead centerline is located within 0.12 mm (0.005 inch) of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS	INCHES
A	7.00 MAX.	0.276 MAX.
B	0.575 MAX.	0.023 MAX.
C	0.65 (T.P)	0.026 (T.P)
D	0.22 ^{+0.10} _{-0.05}	0.009 ^{+0.004} _{-0.002}
E	0.1±0.1	0.004±0.004
F	1.8 MAX.	0.071 MAX.
G	1.5±0.1	0.058±0.004
H	6.4±0.2	0.253±0.008
I	4.4±0.1	0.174±0.004
J	1.0	0.040
K	0.15 ^{+0.10} _{-0.05}	0.060 ^{+0.004} _{-0.002}
L	0.5±0.2	0.020 ^{+0.008} _{-0.004}
M	0.10	0.004
N	0.15	0.006
P	3° ^{+7°} _{-3°}	3° ^{+7°} _{-3°}

RECOMMENDED SOLDERING CONDITIONS

The following conditions (see table below) must be met when soldering this product.

Please consult with our sales officers in case other soldering process is used or in case soldering is done under different conditions.

For details of recommended soldering conditions for surface mounting, refer to information document **SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL (C10535E)**.

μPC2781GR

Soldering process	Soldering conditions	Symbol
Infrared ray reflow	Peak package's surface temperature: 235°C or below, Reflow time: 30 seconds or below (210 °C or higher), Number of reflow process: 3, Exposure limit ^{Note} : None	IR35-00-3
VPS	Peak package's surface temperature: 215 °C or below, Reflow time: 40 seconds or below (200 °C or higher), Number of reflow process: 3, Exposure limit ^{Note} : None	VP15-00-3
Wave soldering	Solder temperature: 260 °C or below, Reflow time: 10 seconds or below, Number of reflow process: 1, Exposure limit ^{Note} : None	WS60-00-1
Partial heating method	Terminal temperature: 300 °C or below, Flow time: 3 seconds or below, Exposure limit ^{Note} : None	

Note Exposure limit before soldering after dry-pack package is opened.

Storage conditions: 25 °C and relative humidity at 65 % or less.

Caution Do not apply more than single process at once, except for “Partial heating method”.

[MEMO]

The application circuits and their parameters are for reference only and are not intended for use in actual design-ins.

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Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots

Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

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Anti-radioactive design is not implemented in this product.

M4 96.5

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